Power MOSFET 60 V, 26.5 mΩ, 20 A, Single N–Channel

Features

- Small Footprint (3.3 x 3.3 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- NVTFS5C680NLWF Wettable Flanks Product
- AEC–Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

Parar	Symbol	Value	Unit		
Drain-to-Source Voltag	V _{DSS}	60	V		
Gate-to-Source Voltage	Э		V _{GS}	±20	V
Continuous Drain		$T_C = 25^{\circ}C$	۱ _D	20	А
Current R _{θJC} (Notes 1, 2, 3, 4)	Steady	T _C = 100°C		14	
Power Dissipation	State	$T_C = 25^{\circ}C$	PD	20	W
$R_{\theta JC}$ (Notes 1, 2, 3)		$T_C = 100^{\circ}C$		10	
Continuous Drain	Steady State	$T_A = 25^{\circ}C$	۱ _D	7.82	А
Current R _{0JA} (Notes 1 & 3, 4)		$T_A = 100^{\circ}C$		6.54	
Power Dissipation		$T_A = 25^{\circ}C$	PD	3.0	W
$R_{\theta JA}$ (Notes 1, 3)		$T_A = 100^{\circ}C$		2.1	
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C, t_p = 10 \ \mu s$			80	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			۱ _S	17	А
Single Pulse Drain–to–Source Avalanche Energy $(I_{L(pk)} = 1 A)$			E _{AS}	51	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State (Note 3)	$R_{\theta JC}$	7.32	°C/W
Junction-to-Ambient - Steady State (Note 3)	R_{\thetaJA}	49	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

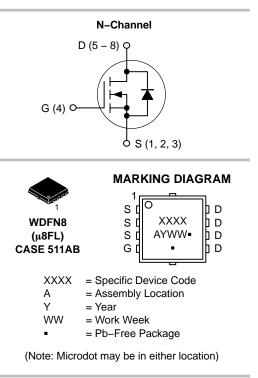
- 2. Psi (Ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.



ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	26.5 mΩ @ 10 V	20 A	
60 V	42.5 mΩ @ 4.5 V	20 A	



ORDERING INFORMATION

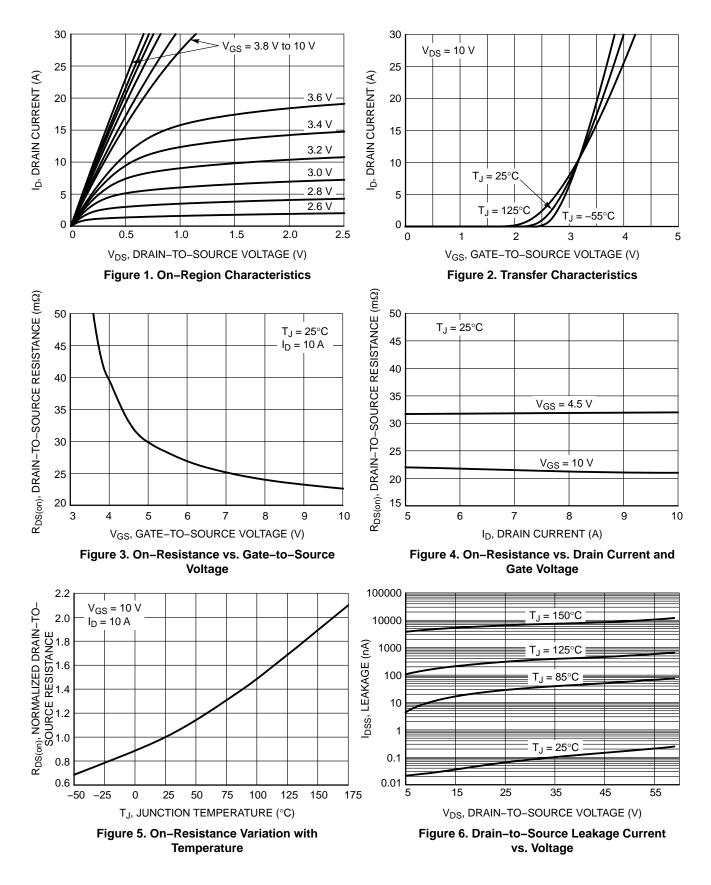
See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

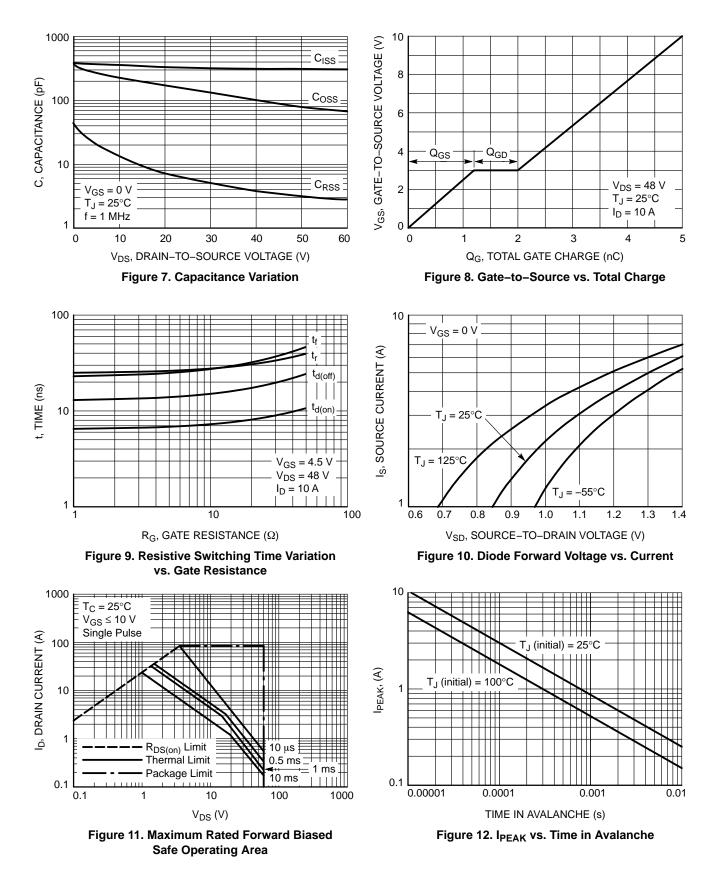
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		•	ı		· ·		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		60			V
Zero Gate Voltage Drain Current	I _{DSS}	$v_{GS} = 0 v$,	$T_J = 25^{\circ}C$			10	μΑ
			T _J = 125°C			100	
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{G}$	_S = +20 V			100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{E}$	_D = 13 μA	1.2		2.2	V
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I	_D = 10 A		22	26.5	mΩ
		V _{GS} = 4.5 V,	I _D = 10 A		34	42.5	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I	_D = 10 A		20		S
CHARGES AND CAPACITANCES							
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1.0 MHz,			327		pF
Output Capacitance	C _{oss}	V _{DS} = 2	5 V		161		
Reverse Transfer Capacitance	C _{rss}				6.0		
Total Gate Charge	Q _{G(TOT)}				2.9		nC
Threshold Gate Charge	Q _{G(TH)}				0.8		nC
Gate-to-Source Charge	Q _{GS}	V_{GS} = 4.5 V, V_{DS} = 48 V, I_{D} = 10 A			1.2		
Gate-to-Drain Charge	Q _{GD}				0.8		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 10 V, V_{DS} =	48 V, I _D = 10 A		6.0		nC
SWITCHING CHARACTERISTICS (No	te 6)						
Turn–On Delay Time	t _{d(on)}				6.5		ns
Rise Time	t _r	V _{GS} = 4.5 V, V	s = 48 V,		25		
Turn-Off Delay Time	t _{d(off)}	V _{GS} = 4.5 V, V I _D = 10 A, R _C	₃ = 1.0 Ω		13		
Fall Time	t _f				23		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	d Diode Voltage V_{SD} $V_{GS} = I_S = 1$	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$		0.9	1.2	V
		I _S = 10 A	T _J = 125°C		0.8		1
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, dl _S /dt = 100 A/µs, I _S = 10 A			17		ns
Charge Time	t _a				8.0		
Discharge Time	t _b				9.0		1
Reverse Recovery Charge	Q _{RR}				7.0		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

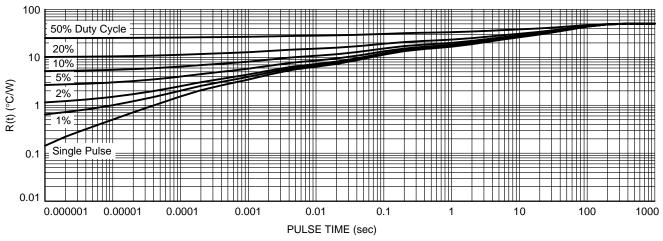


Figure 13. Thermal Characteristics

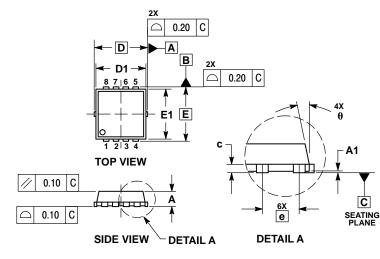
DEVICE ORDERING INFORMATION

Device	Marking	Package	Shipping [†]
NVTFS5C680NLTAG	680L	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS5C680NLWFTAG	80LW	WDFN8 (Pb–Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D



0.10 С A В ŧ 0.05 С e/2 4X E2 F3 м V D2 G-**BOTTOM VIEW**

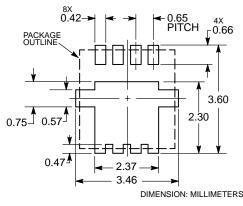
NOTES:

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 3.

	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0.130 BSC		
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
Е		3.30 BSC		0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
к	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and 💷 are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdl/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typical" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that ON Semiconductor was negligent regarding the design or manufacture of the part. ON Semiconductor is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative